

## **TEST REPORT**

Applicant:	Shenzhen Yipincheng Technology Co., Ltd
Address of Applicant:	4F, Building A, Hengchangrong Industrial Park, Pinghu Street, Longgang District, Shenzhen
Factory:	Shenzhen Yipincheng Technology Co., Ltd
Address of Factory:	4F, Building A, Hengchangrong Industrial Park, Pinghu Street, Longgang District, Shenzhen
Equipment Under Test (E	EUT)
Product Name:	Children' s Digital Camera
Model No.:	Q1, X18, X200, X300, X400, X500, X600, X700, X800, inskam127, inskam128, inskam129, inskam112, inskam113, inskam115, inskam306, inskam307, inskam315, inskam209, inskam317, p50
Trade Mark:	N/A
Applicable standards:	EN 55032:2015/AC:2016 EN 55035:2017 EN 61000-3-2:2014 EN 61000-3-3:2013
Date of sample receipt:	September 21, 2020
Date of Test:	Oct. 12- 20, 2020
Date of report issued:	Oct. 20, 2020
Test Result :	PASS *

\* In the configuration tested, the EUT complied with the standards specified above.

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EC Declaration of Conformity and compliance with all relevant EC Directives. The protection requirements with respect to electromagnetic compatibility contained in Directive 2014/30/EU are considered.

CE

This results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.



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## 2 Version

Version No.	Date	Description
00	Oct. 20, 2020	Original

orator Prepared by: Date: Oct. 20, 2020 Proje it (r n nc **Reviewed by:** Date: repor Oct. 20, 2020 **Designated Reviewer** 



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## 4 Test Summary

Test item	Test Requirement	Test Method	Class / Severity	Result
Radiated Emission	EN 55032	EN 55032	Class B	Pass
Conducted Emission	EN 55032	EN 55032	Class B	Pass
Harmonic Emission	EN 61000-3-2	EN 61000-3-2	N/A	N/A
Flicker Emission	EN 61000-3-3	EN 61000-3-3	Clause 5	Pass
Electrostatic discharge	EN 55035	EN 61000-4-2	Contact ±2,±4 kV Air ±2,±4,±8 kV	Pass
Radio-frequency electromagnetic field Amplitude modulated	EN 55035	EN 61000-4-3	3V/m 80%, 1kHz, AM	Pass
Electrical fast transients	EN 55035	EN 61000-4-4	$AC \pm 1.0 kV$	Pass
Surges	EN 55025	EN 61000-4-5	±1kV D.M	Pass
Surges	EN 55055		±2kV C.M	
Radio-frequency continuous conducted	EN 55035	EN 61000-4-6	3Vrms (emf), 80%, 1kHz Amp. Mod.	Pass
Voltage dips and Voltage interruptions	EN 55035	EN 61000-4-11	0 % U⊤* for 0.5per 0 % U⊤* for 250per 70 % U⊤* for 25per	Pass

Remark:

- 1. Pass: Comply with the essential requirements in the standard.
- 2. N/A: not applicable
- 3. UT: the nominal supply voltage; D.M: Differential Mode; C.M: Common Mode.



## **5** General Information

## 5.1 General Description of EUT

Product Name:	Children' s Digital Camera		
Model No.:	Q1, X18, X200, X300, X400, X500, X600, X700, X800, inskam127, inskam128, inskam129, inskam112, inskam113, inskam115, inskam306		
	inskam 120, inskam 123, inskam 12, inskam 13, inskam 13, inskam 150, inskam 307, inskam 315, inskam 209, inskam 317, p50		
Test Model No.:	Q1		
Remark: All above models circuits. The only difference	s are identical in the same PCB layout, interior structure and electrical ce is the model name for commercial purpose.		
Hardware Version:	-		
Software Version: -			
Power Supply:	5VDC, 1000mA		
5.2 Test mode and Test	voltage		

# Test mode: Adapter mode LAN mode Test voltage: 5VDC

#### 5.3 Description of Support Units

Manufacturer	Description	Model	Serial Number
Anker	ADAPTER	A2132	N/A

#### 5.4 Deviation from Standards

None.



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### 5.5 Abnormalities from Standard Conditions

Road, Baoan District, Shenzhen, Guangdong, China

Tel: 0755-27798480 Fax: 0755-27798960

	None.						
5.6	Monitori	Monitoring of EUT for All Immunity Test					
	Visual:	Visual: Monitor the screen.					
	Audio: Monitor the sound.						
5.7	Test Location						
	RI test was performed at:						
	SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch E&E Lab, No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.						
	All other te	ests were performed at:					
	Global Uni	ted Technology Services Co., Ltd.					

Address: No. 123- 128, Tower A, Jinyuan Business Building, No.2, Laodong Industrial Zone, Xixiang

RED Laboratories Inc. Room 110, Buliding A, ZhengTaiLai Hi-Tech Innovation Park, No. 221, Gonghe Industrial Road, Xixiang Street, Bao'an District, Shenzhen, China



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## 6 Test Instruments List

Rad	Radiated Emission:								
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)			
1	3m Semi- Anechoic Chamber	ZhongYu Electron	9.2(L)*6.2(W)* 6.4(H)	GTS250	July. 03 2015	July. 02 2020			
2	Control Room	ZhongYu Electron	6.2(L)*2.5(W)* 2.4(H)	GTS251	N/A	N/A			
3	EMI Test Receiver	Rohde & Schwarz	ESU26	GTS203	June. 27 2019	June. 26 2020			
4	BiConiLog Antenna	SCHWARZBECK MESS-ELEKTRONIK	VULB9163	GTS214	June. 27 2019	June. 26 2020			
5	Double -ridged waveguide horn	SCHWARZBECK MESS-ELEKTRONIK	BBHA 9120 D	GTS208	June. 27 2019	June. 26 2020			
6	Horn Antenna	ETS-LINDGREN	3160	GTS217	June. 27 2019	June. 26 2020			
7	EMI Test Software	AUDIX	E3	N/A	N/A	N/A			
8	Coaxial Cable	GTS	N/A	GTS213	June. 27 2019	June. 26 2020			
9	Coaxial Cable	GTS	N/A	GTS211	June. 27 2019	June. 26 2020			
10	Coaxial cable	GTS	N/A	GTS210	June. 27 2019	June. 26 2020			
11	Coaxial Cable	GTS	N/A	GTS212	June. 27 2019	June. 26 2020			
12	Amplifier(100kHz-3GHz)	HP	8347A	GTS204	June. 27 2019	June. 26 2020			
13	Amplifier(2GHz-20GHz)	HP	84722A	GTS206	June. 27 2019	June. 26 2020			
14	Amplifier (18-26GHz)	Rohde & Schwarz	AFS33-18002 650-30-8P-44	GTS218	June. 27 2019	June. 26 2020			
15	Band filter	Amindeon	82346	GTS219	June. 27 2019	June. 26 2020			
16	Power Meter	Anritsu	ML2495A	GTS540	June. 27 2019	June. 26 2020			
17	Power Sensor	Anritsu	MA2411B	GTS541	June. 27 2019	June. 26 2020			
18	Wideband Radio Communication Tester	Rohde & Schwarz	CMW500	GTS575	June. 27 2019	June. 26 2020			
19	Splitter	Agilent	11636B	GTS237	June. 27 2019	June. 26 2020			
20	Loop Antenna	ZHINAN	ZN30900A	GTS534	June. 27 2019	June. 26 2020			
21	Breitband hornantenne	SCHWARZBECK	BBHA 9170	GTS579	Oct. 20 2019	Oct. 19 2020			
22	Amplifier	TDK	PA-02-02	GTS574	Oct. 20 2019	Oct. 19 2020			
23	Amplifier	TDK	PA-02-03	GTS576	Oct. 20 2019	Oct. 19 2020			
24	PSA Series Spectrum Analyzer	Rohde & Schwarz	FSP	GTS578	June. 27 2019	June. 26 2020			



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Conducted Emission							
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)	
1	Shielding Room	ZhongYu Electron	7.3(L)x3.1(W)x2.9(H)	GTS252	May.15 2019	May.14 2022	
2	EMI Test Receiver	R&S	ESCI 7	GTS552	June. 27 2019	June. 26 2020	
3	Coaxial Switch	ANRITSU CORP	MP59B	GTS225	June. 27 2019	June. 26 2020	
4	Artificial Mains Network	SCHWARZBECK MESS	NSLK8127	GTS226	June. 27 2019	June. 26 2020	
5	Coaxial Cable	GTS	N/A	GTS227	N/A	N/A	
6	EMI Test Software	AUDIX	E3	N/A	N/A	N/A	
7	Thermo meter	KTJ	TA328	GTS233	June. 27 2019	June. 26 2020	
8	Absorbing clamp	Elektronik- Feinmechanik	MDS21	GTS229	June. 27 2019	June. 26 2020	

ESD	ESD						
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)	
1	ESD Simulator	KIKUSUI	KES4021A	GTS242	June. 27 2019	June. 26 2020	
2	Thermo meter	KTJ	TA328	GTS243	June. 27 2019	June. 26 2020	

Conc	Conducted Immunity							
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)		
1	Signal Generator	ROHDE & SCHWARZ	SMB 100A	GTS553	June. 27 2019	June. 26 2020		
2	CDN	LionCEL	CDN-M3-16	GTS554	June. 27 2019	June. 26 2020		
3	CDN	CYBERTEK	EM 5070	GTS559	June. 27 2019	June. 26 2020		
4	Power amplifier	rflight	NTWPA-00010475	GTS555	June. 27 2019	June. 26 2020		
5	ATT	SUNWAVE	SJ-50-06DB	GTS556	June. 27 2019	June. 26 2020		
6	Clamp	SCHAFFNER	KEMZ 801	GTS558	June. 27 2019	June. 26 2020		

Harmonic/ Flicker						
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)
1	Power Analyzer H/F	EMTEST	DPA500	GTS235	June. 27 2019	June. 26 2020
2	AC POWER SUPPLY	EMTEST	ACS500	GTS236	June. 27 2019	June. 26 2020
3	Thermo meter	KTJ	TA328	GTS256	June. 27 2019	June. 26 2020



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EFT, Su	EFT, Surge, Voltage dips and Interruption								
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)			
1	EMTEST system	EMTEST	UCS500N	GTS239	June. 27 2019	June. 26 2020			
2	Clamp	EMTEST	HFK	GTS557	June. 27 2019	June. 26 2020			
3	Thermo meter	KTJ	TA328	GTS238	June. 27 2019	June. 26 2020			

Radiated Immunity					
Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy -mm-dd)	Cal. Due date (yyyy- mm-dd)
Fully-Anechoic Chamber 2	Chang Zhou Zhong Shuo	854	SEM001-05	2017-05-10	2020-05-09
Power Sensor	Rohde & Schwarz	NRP-Z91	SEM009-09	2019-04-01	2020-03-31
Stacked LogPerBroadband Antenna (70MHz-10GHz)	Schwarzbeck	STLP 9129	SEM003-25	N/A	N/A
Signal Generator (9kHz-6GHz)	Rohde & Schwarz	SMB100A	SEM006-11	2019-04-01	2020-03-31
Broadband Amplifier (80MHz-1GHz)	Rohde & Schwarz	BBA150-BC250	SEM005-12	2019-09-25	2020-09-24
Broadband Amplifier (800MHz-3GHz)	Rohde & Schwarz	BBA150-D110	SEM005-13	2019-04-01	2020-03-31
Broadband Amplifier (2.5GHz-6GHz)	Rohde & Schwarz	BBA150-E60	SEM005-16	2019-04-12	2020-04-11
Measurement Software	Rohde & Schwarz	EMC32 V9.25.00	N/A	N/A	N/A

Gene	General used equipment:									
ltem	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal.Date (mm-dd-yy)	Cal.Due date (mm-dd-yy)				
1	Humidity/ Temperature Indicator	KTJ	TA328	GTS243	June. 27 2019	June. 26 2020				
2	Barometer	ChangChun	DYM3	GTS255	June. 27 2019	June. 26 2020				



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## 7 Emission Test Results

## 7.1 Radiated Emission

Test Requirement:	EN 55032							
Test Method:	EN 55032							
Test Frequency Range:	30MHz to 6GHz							
Class / Severity:	Class B							
Test site:	Measurement Di	stance: 3m						
Receiver setup:								
•	Frequency	Detecto	or	RBW	VBV	V	Value	
	30MHz-1GHz	Quasi-pe	ak	120KHz	300KI	Hz	Quasi-peak	
	Above 1GHz	Peak		1MHz	3MH	z	Peak	
	7,6676 16112	AV		1MHz	3MH	Z	Average	
Limit:								
	Frequen	су	Lin	nit (dBµV/m	@3m)		Value	
	30MHz-230	<u>MHz</u>		40.00		(	Quasi-peak	
	230MHZ-1	GHZ		47.00		(	Quasi-peak	
	1GHz-30			50.00				
	3GHz-60	Hz		74.00			Peak	
	3GHz-6G	GHz		54.00		Average		
Test setup:	Below 1GHz:							
	Antenna Tower u date of the second Plane date							
AE EUT Turntable) Ground Reference Plane Test Receiver Angular Arguing Controller								



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Test Procedure:	From 30MH	z to 1GHz:					
	1. The radia chamber.	ted emissio	ns test was c	onducted ir	n a semi-an	echoic	
	2. The tablet the ground EUT was separated 0.1m of in	top EUT wa d reference placed on th from metal sulation.	s placed upo plane. And fo ne horizontal lic contact wi	n a non-me or floor-star ground refe th the grou	etallic table ( ading arrang erence plan ad referenc	0.8m above gement, the e, but e plane by	
	3. Before fin performec maximum	al measure I in the spec emissions	ments of radi ctrum mode v spectrum plo	ated emiss vith the pea ts of the EL	ions, a pre- k detector t JT.	scan was o find out the	
	4. The frequ radiated e rotated 36 meters in were perfo	encies of m missions m 0°, and the order to det ormed for bo	aximum emis easurement. antenna was ermine the m oth horizonta	ssion were At each fre raised and naximum dia l and vertica	determined quency, the l lowered fro sturbance. I al antenna p	in the final EUT was om 1 to 4 Measurements polarization.	
	Above 1GHz:						
	1. The radiated emissions test was conducted in a fully-anechoic chamber.						
	2. The tabletop EUT was placed upon a non-metallic table 0.8m above the ground reference plane. And for floor-standing arrangement, the EUT was placed on the horizontal ground reference plane, but separated from metallic contact with the ground reference plane by 0.1m of insulation.						
	3. Before final measurements of radiated emissions, a pre-scan was performed in the spectrum mode with the peak detector to find out the maximum emission spectrum plots of the EUT.						
	4. The frequencies of maximum emission were determined in the final radiated emissions measurement. At each frequency, the EUT was rotated 360°, and the antenna was raised and lowered from 1 to 4 meters in order to determine the maximum disturbance. Measurements were performed for both horizontal and vertical antenna polarization.						
Test environment:	Temp.:	25 °C	Humid.:	52%	Press.:	1 012mbar	
Measurement Record:					Uncertaint	y: ± 4.50dB	
Test Instruments:	Refer to sec	tion 6.0 for	details				
Test mode:	Refer to sec	tion 5.2 for	details.				
Test results:	Pass						



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#### **Measurement Data**



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		818.8341	36.18	-0.84	35.34	47.00	-11.66	peak			
2		866.0879	35.67	-0.50	35.17	47.00	-11.83	peak			
3	*	986.0717	34.70	1.11	35.81	47.00	-11.19	peak			



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No	. Mk.	Freq.	Level	Factor	ment	Limit	Over		Height	Degree	
		MHz	dBuV	dB/m	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		216.0240	49.86	-13.35	36.51	46.00	-9.49	peak			
2		807.4291	37.22	-0.77	36.45	46.00	-9.55	peak			
3	*	938.8326	39.11	0.90	40.01	46.00	-5.99	peak			



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Test Requirement:	EN 55032							
Test Method:	EN 55032							
Test Frequency Range:	150kHz to 30MHz							
Class / Severity:	Class B							
Receiver setup:	RBW=9kHz, VBW=30kHz							
Limit:								
	Frequency range (MHz)		Limit (dBµV)	)				
	0.15-0.5	Quasi-pear	K	Average				
	0.5-5	56		46				
	5-30	60		50				
	* Decreases with the logarith	m of the frequence	cy.					
Test setup:	Reference F	lane						
	LISN 40cm 8 40cm 8 40cm 8 EUT EuT Test table/Insulation plane Remark E U T Equipment Under Test LISN: Line Impedence Stabilization Networ Test table height=0.8m	Ocm Filter EMI Receiver	r] AC pov	wer				
Test procedure:	1. The E.U.T and simulators line impedance stabilizatio 50ohm/50uH coupling imp	are connected to n network(LISN). edance for the m	the main po The provide easuring eq	ower through a e a juipment.				
	2. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refers to the block diagram of the test setup and photographs).							
	3. Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to EN55032 Class B on conducted measurement.							
Test environment:	Temp.: 24 °C Humid	.: 51%	Press.:	1012mbar				
Measurement Record:		-	Uncerta	inty: ±3.45dB				
Test Instruments:	Refer to section 6 for details							
Test mode:	Refer to section 5.2 for details.							
Test results:	Pass		Pass					

## 7.2 Conducted Emission



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Note:

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.1620	44.36	-0.13	44.23	65.36	-21.13	peak	
2		0.1620	34.20	-0.13	34.07	55.36	-21.29	AVG	
3		0.2819	29.79	-0.01	29.78	50.76	-20.98	AVG	
4		0.2860	40.61	-0.01	40.60	60.64	-20.04	peak	
5		0.6260	39.39	-0.05	39.34	56.00	-16.66	peak	
6		0.6260	30.05	-0.05	30.00	46.00	-16.00	AVG	
7		7.6820	27.89	-0.28	27.61	50.00	-22.39	AVG	
8		7.8060	36.63	-0.25	36.38	60.00	-23.62	peak	
9		24.0020	39.47	-0.43	39.04	60.00	-20.96	peak	
10	•	24.0020	35.27	-0.43	34.84	50.00	-15.16	AVG	
11		29.9980	29.49	-0.41	29.08	60.00	-30.92	peak	
12		30.0000	23.54	-0.41	23.13	50.00	-26.87	AVG	

\*:Maximum data x:Over limit !:over margin



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No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	0.1620	44.35	-0.13	44.22	65.36	-21.14	peak	
2	0.1620	35.18	-0.13	35.05	55.36	-20.31	AVG	
3	0.6260	39.72	-0.05	39.67	56.00	-16.33	peak	
4 *	0.6260	29.87	-0.05	29.82	46.00	-16.18	AVG	

\*:Maximum data x:Over limit !:over margin



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#### 7.3 Harmonic Emission

Test Requirement:	EN 61000-3-2
Test Method:	N/A: See Remark Below
Remark	There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2.
	For further details, please refer to Clause 7, Note 1 of EN 61000-3-2 which states:
	"For the following categories of equipment limits are not specified in this edition of the standard.
	Note 1: Equipment with a rated power of 75W or less, other than lighting equipment."

#### 7.4 Flicker Emission

Test Requirement:	EN 61000-3-3						
Test Method:	EN 61000-3-3						
Class/Severity:	Clause 5 of EN 61000-3-3						
Measurement Time:	10 min						
Detector:	As per EN 61000-3-3						
Test environment:	Temp.: - Humid.: - Press.: -						
Test Instruments:	-						
Test mode:	-						
Test results:	-						



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## 8 Immunity Test Results

## 8.1 Performance Criteria Description in Clause 7 of EN 55035

Criterion A:	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B:	After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.
	During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.
	If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C:	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.
	Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



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•		-			
	Test Requirement:	EN 55035			
	Test Method:	EN 61000-4-2			
	Discharge Voltage:	Contact Discharge: ±2kV, ±4kV			
		Air Discharge: ±2kV, ±4kV, ±8kV			
		HCP/VCP: ±2kV, ±4kV			
	Polarity:	Positive & Negative			
	Number of Discharge:	Contact Discharge: Minimum 25 times at each test point,			
		Air Discharge: Minimum 10 times at each test point.			
	Discharge Mode:	Single Discharge			
	Discharge Period:	1 second minimum			
	Performance Criterion:	Criterion B			
	Test setup:	Electrostatic Discharge EUT VCP(0.5m°0.5m) TOK ohm -Insulating Support(0.5mr) TOK ohm -Insulating Su			
	Test Procedure:	1. Air discharge:			
		The test was applied on non-conductive surfaces of EUT. The round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure was repeated until all the air discharge completed <b>2.</b> Contact Discharge:			
		The test was applied on conductive surfaces of FLIT, the generator was			
		re-triggered for a new single discharge and repeated 25 times for each pre-selected test point. the tip of the discharge electrode was touch the EUT before the discharge switch was operated.			
		3. Indirect discharge for horizontal coupling plane			
		At least 10 single discharges shall be applied at the front edge of each HCP opposite the centre point of each unit of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.			
		Consideration should be given to exposing all sides of the EUT.			
		4. Indirect discharge for vertical coupling plane			
		At least 10 single discharges were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, was placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges were applied to the coupling plane, with this plane in			

## 8.2 Electrostatic discharge



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	sufficient different positions that the four faces of the EUT are completely illuminated.					
Test environment:	Temp.:	24 °C	Humid.:	51%	Press.:	1 012mbar
Test mode:	Refer to sec	tion 6.0 for	details			
Test Instruments:	Refer to section 5.2 for details					
Test results:	Pass					

#### Measurement Record:

Test points:	I: N/A II: Please refer to red ring in below plots			
rest points.				
Direct discharge				
Discharge			Observations	
Voltage (KV)	Type of discharge	Test points	(Performance Criterion)	Result
± 2, ± 4	-	-	-	N/A
+2 + 4 + 8	Δir	Ш	Δ	Dass
⊥ ∠, ⊥ 4,⊥ 0		11	~	F 855
Indirect discharge		"		F 855
Indirect discharge		Tost points	Observation	Pocult
Indirect discharge Discharge Voltage (KV)	Type of discharge	Test points	Observation Performance	Result
Indirect discharge Discharge Voltage (KV)	Type of discharge	Test points	Observation Performance	Result
Indirect discharge Discharge Voltage (KV) $\pm 2, \pm 4$	Type of discharge HCP-Bottom/Top/ Front/Back/Left/Right	Test points Edge of the HCP	Observation Performance A	Result Pass
Indirect discharge Discharge Voltage (KV) $\pm 2, \pm 4$	Type of discharge HCP-Bottom/Top/ Front/Back/Left/Right VCP-Front/Back	Test points Edge of the HCP	Observation Performance A	Result Pass

Remark:

A: Normal performance within the specification limits.

N/A: Not applicable.



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#### ESD test point:



#### Remark: Red Ring: air discharge test points



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## 8.3 Radio-frequency electromagnetic field Amplitude modulated

Test Requirement:	EN 55035
Test Method:	EN 61000-4-3
Frequency range:	80MHz to 1GHz
Test Level:	3V/m
Modulation:	80%, 1kHz Amplitude Modulation
Performance Criterion:	Criterion A
Test setup:	Camera Camera Camera Camera Camera Antenna Tower AE EUT (Turntable) Ground Reference Plane Generator Power Amplifier
Test Procedure:	<ol> <li>For table-top equipment, the EUT was placed in the chamber on a non-conductive table 0.8m high. For arrangement of floor-standing equipment, the EUT was mounted on a non-conductive support 0.1m above the supporting plane. For human body-mounted equipment, the EUT may be tested in the same manner as table top items.</li> <li>If possible, a minimum of 1 m of cable is exposed to the electromagnetic field. Excess length of cables interconnecting units of the EUT shall be bundled low-inductively in the approximate center of the cable to form a bundle 30 cm to 40 cm in length.</li> <li>The EUT was initially placed with one face coincident with the calibration plane. The EUT face being illuminated was contained within the UFA (Uniform Field Area).</li> <li>The frequency ranges to be considered were swept with the signal modulated and pausing to adjust the RF signal level or to switch oscillators and antennas as necessary.Where the frequency range was swept incrementally, the step size was not exceed 1 % of the preceding frequency value.</li> <li>The dwell time of the amplitude modulated carrier at each frequency was not be less than the time necessary for the EUT to be exercised and to respond, and was not less than 0,5 s.</li> <li>The test normally was performed with the generating antenna facing each side of the EUT.</li> <li>The polarization of the field generated by each antenna necessitates testing each selected side twice, once with the antenna positioned</li> </ol>
	<ul><li>vertically and again with the antenna positioned horizontally.</li><li>8. The EUT was performed in a configuration to actual installation</li></ul>



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	conditions, a video camera and/or a audio monitor were used to monitor the performance of the EUT.					
Test environment:	Temp.:	-	Humid.:	-	Press.:	-
Test Instruments:	-					
Test mode:	-					
Test results:	-					



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## 8.4 Electrical fast transients

Test Requirement:	EN 55035
Test Method:	EN 61000-4-4
Test Level:	1.0kV
Polarity:	Positive & Negative
Test signal specification:	Rise time=5ns, Duration time=50ns; Burst Duration=15ms, Burst Period=300ms; Repetition Frequency=5KHz
Test Duration:	2 minute per level & polarity
Performance Criterion:	Criterion B
Test setup:	EMC Tester EUT 10cm 10
	Ground Reference Plane
Test Procedure:	<ol> <li>The EUT and its simulators were placed on the ground reference plane and were insulated from it by a wood support 0.1m + 0.01m thick. The ground reference plane was 1m*1m metallic sheet with 0.65mm minimum thickness.</li> <li>This reference ground plane was project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane was more than 0.5m.</li> <li>All cables to the EUT was placed on the wood support, cables not subject to EFT/B was routed as far as possible from the cable under test to minimize the coupling between the cables.</li> <li>The length of power lines between the coupling device and the EUT is 0.5m</li> <li>The EUT is connected to the power mains through a coupling device that directly couples the EFT/B interference signal.</li> <li>Each of the Line and Neutral conductors is impressed with burst noise for 2 minutes.</li> </ol>
Test environment:	Temp.: - Humid.: - Press.: -
Test Instruments:	-
Test mode:	-



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#### 8.5 Surges

Test Requirement:	EN 55035				
Test Method:	EN 61000-4-5				
Test Level:	1kV line to line: Differential mode				
	2kV line to earth: Common mode				
Polarity:	Positive & Negative				
Generator source	2Ω (line-line coupling)				
impedance:	12Ω (line-earth coupling)				
Test signal specification:	Rise time=1.2us, Duration time=50us;				
	Test Interval: 60s between each surge;				
No. of surges:	5 positive, 5 negative at 0°, 90°, 180°, 270°.				
Performance Criterion:	Criterion B				
Test setup:	EMC Tester EUT egg Non-conducted table Ground Reference Plane				
Test Procedure:	<ol> <li>For line-to-line coupling mode, provide a 1kV 1.2/50us voltage su (at open-circuit condition) and 8/20us current surge to EUT select points, and for active line / neutral lines to ground are same excert test level is 2kV.</li> <li>At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are applied during test.</li> <li>Different phase angles are done individually.</li> <li>Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.</li> </ol>				
Test environment:	Temp.: - Humid.: - Press.: -				
Test Instruments:	<u>▶                                    </u>				
Test mode:	-				
Test results:					



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## 8.6 Radio-frequency continuous conducted

Test Requirement:	EN 55035			
Test Method:	EN 61000-4-6			
Frequency range:	0.15MHz to 80MHz			
Test Level:	3V rms on AC Ports (unmodulated emf into 150 $\Omega$ )			
Performance Criterion:	Criterion A			
Test setup:	Shielding Room Signal Generator Amplifier Non-conducted Table Ground Reference Plane Ground Reference Plane			
Test Procedure:	<ol> <li>The EUT are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).</li> <li>The disturbance signal described below is injected to EUT through CDN.</li> <li>The EUT operates within its operational mode(s) under intended climatic conditions after power on.</li> <li>Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.</li> </ol>			
Test environment:	Temp.: - Humid.: - Press.: -			
Test Instruments:	-			
Test mode:	-			
Test results:	-			



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## 8.7 Voltage dips and Voltage interruptions

Test Requirement:	EN 55035
Test Method:	EN 61000-4-11
Test Level:	0% of VT(Supply Voltage) for 0.5 period
	70% of VT(Supply Voltage) for 25 period
	0% of VT(Supply Voltage) for 250 period
Number of Dips / Interruptions:	3 per Level
Performance Criterion:	>95% VD, 0.5 periodPerformance criterion: B
	30% VD, 25 periodPerformance criterion: C
	>95% VI, 250 periodPerformance criterion: C
Test setup:	EMC Tester EUT equip Building
Test Procedure:	<ol> <li>The EUT and test generator were setup as shown on above setup photo.</li> <li>The interruptions are introduced at selected phase angles with specified duration.</li> <li>Record any degradation of performance.</li> </ol>
Test environment:	Temp.: - Humid.: - Press.: -
Test Instruments:	-
Test mode:	-
Test results:	-



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## 9 Test Setup Photo

Conducted Emission





## 10 EUT Constructional Details



Photo 1: Outside overview



Photo 2: Outside overview



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Photo 3: Outside overview



Photo 4: Outside overview



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Photo 5: Outside overview



Photo 6: Outside overview

-----End-----